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## RELIABILITY REPORT

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## Reliability Data Report Product Family R545

LT3070 / LT3071

## Reliability Data Report Report Number: R545 Report generated on: Mon Mar 05 11:01:10 PST 2018

PACKAGE TYPE	SAMPLE SIZE	OLDEST DATE	NEWEST DATE	K DEVICE HRS	No. of FAILURES
		CODE	CODE	(+125°C) <sup>¹</sup>	2,3
QFN/DFN	77	0910	0910	77	0
Totals	77	-	-	77	0
PRESSURE CO	OOKER TEST A	T 15 PSIG , +12	1 DEG C		
PACKAGE TYPE	SAMPLE SIZE	OLDEST DATE	NEWEST DATE	K DEVICE HRS	No. of FAILURES
		CODE	CODE		
QFN/DFN	1098	0910	1648	74	0
Totals	1,098	-	-	74	0
TEMP CYCLE	FROM -65 TO 1	50 DEG C			
PACKAGE TYPE	SAMPLE SIZE	OLDEST DATE	NEWEST DATE	K DEVICE	No. of FAILURES
		CODE	CODE	CYCLES	
QFN/DFN	1200	0910	1648	258	0
	1 000	<u> </u>	-	258	0
Totals	1,200				
	DCK FROM -65	TO 150 DEG C			
		TO 150 DEG C OLDEST DATE	NEWEST DATE	K DEVICE	No. of FAILURES
THERMAL SHO	OCK FROM -65		NEWEST DATE CODE	K DEVICE CYCLES	No. of FAILURES
THERMAL SHO	OCK FROM -65	OLDEST DATE	_	_	No. of FAILURES

Note: 1 FIT = 1 Failure in One Billion Hours. Note 2: HAST, Temp Cycle & Thermal Shock are subjected to J-STD-020 MSL1 Preconditioning